

ID	R _{DS} (ON)(Typ)	VDSS
17.6A	165mΩ	600V

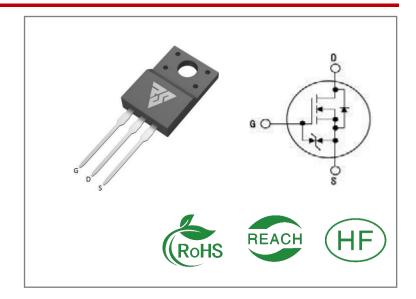
Applications:

- Switch Mode Power Supply(SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)
- AC-DC Switching Power Supply

Features:

- Fast switching speed
- 100% avalanche tested
- Improved dv/dt capability
- Fast Recovery Time





Part Number	Package	Marking	Packing	Qty.
RSF60R190F	T0-220F	RSF60R190F	Tube	50 PCS

Absolute Maximun Ratings Tc= 25℃ unless otherwise specified

Symbol	Parameter	RSF60R190F	Units
VDSS	Drain-to-Source Voltage	600	V
ID	Continuous Drain Current TC=25℃	17.6	
ID	Continuous Drain Current TC=100℃	11.2	А
IDM	Pulsed Drain Current (Note*1)	53	
PD	Power Dissipation	33	W
VGS	Gate- to- Source Voltage	±20	V
	Single Pulse Avalanche Engergy		
EAS	IAS=2.45A,VDD = 50V, RG = 25 Ω , TC=25 $^{\circ}$ C	262	mJ
dv/dt	MOSFET dv/ dt ruggedness VDS = 0400V	50	V/ns
dv/dt	Reverse diode dv/dt VDS = 0400V, Tj = 25°C, ISD≤ID	15	V/ns
VESD(G-S)	Gate source ESD(HBM-C=100pF, R=1.5KΩ)	2000	V
	Maximum Temperature for Soldering	300	
TL TPKG	Leads at 0.063in(1.6mm)from Case for 10 seconds	260	
	Package Body for 10 seconds		\mathbb{C}
TJ and	Operating Junction and Storage	-55 to 150	
TSTG	Temperature Range		

^{*} Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.

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Thermal Resistance

Symbol	Parameter	RSF60R190F	Units	Test Conditions
RθJC	Junction-to-Case	3.77	°C/ W	Drain lead soldered to water cooled heatsink, PD adjusted for a peak junction temperature of + 1 5 0 $^{\circ}\mathrm{C}$
RθJA	Junction-to- Ambient	80		1 cubic foot chamber,free air.

OFF Characteristics TJ= 25° C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVDSS	Drain- to- source Breakdown Voltage	600			V	VGS=0V,ID=1mA
IDSS	Drain- to- Source Leakage Current			1	μΑ	VDS=600V,VGS=0 V
	Gate- to- Source Forward Leakage			1	_	VGS=20V ,VDS=0V
IGSS	Gate- to- Source Reverse Leakage			-1	μΑ	VGS=-20V ,VDS=0 V

ON Characteristics TJ=25 °C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
RDS(on)	Static Drain- to- Source On- Resistance(Note*2)		165	190	mΩ	VGS=10V,ID=6.9A
VGS(TH)	Gate Threshold Voltage	2.5		5	V	VGS=VDS,ID=670μ A

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn- on Delay Time		39			
trise	Rise Time		21		C	VDS=300V
td(OFF)	Turn- OFF Delay Time		171		nS	ID=8.7A RG=25Ω
tfall	Fall Time		18			



Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ciss	Input Capacitance		1750			VGS=0V
Coss	Output Capacitance		41		pF	VDS=400V
Crss	Reverse Transfer Capacitance		2.2			f=1.0MHz
Qg	Total Gate Charge		40			VDS=480V
Qgs	Gate- to- Source Charge		8		nC	ID=8.7A
Qgd	Gate-to-Drain(" Miller") Charge		12			VGS=10V

Source-Drain Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
IS	Continuous Source Current			17.6	Α	Integral pn- diode
ISM	Maximum Pulsed Current			53	Α	in MOSFET
VSD	Diode Forward Voltage			1.3	V	IS=8.7A,VGS=0V
trr	Reverse Recovery Time		149		nS	VR=400V
Qrr	Reverse Recovery Charge		0.92		μС	IS=8.7A,di/dt=100 A/μs

Notes:

^{* 1.} Repetitive rating, pulse width limited by maximum junction temperature.

^{* 2.} Pulse Test: Pulse width ≤ 300µs, Duty Cycle ≤ 2%



Typical Feature Curve

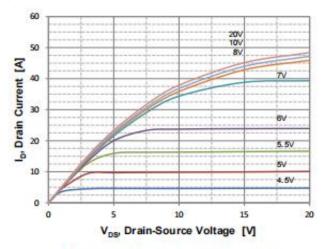


Figure 1. On Region Characteristics

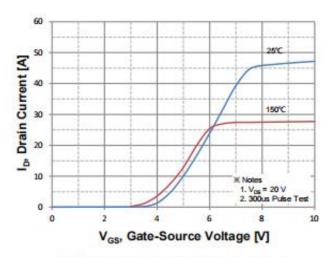


Figure 2. Transfer Characteristics

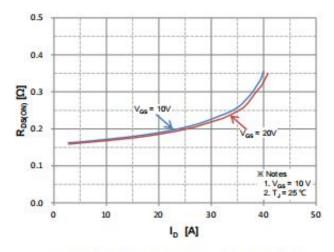


Figure 3. On Resistance Variation vs Drain Current and Gate Voltage

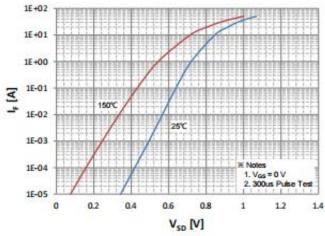


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

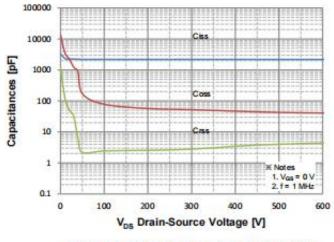


Figure 5. Capacitance Characteristics

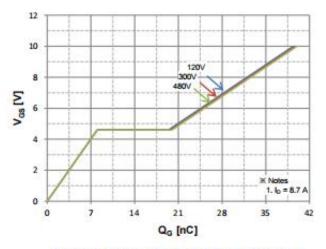


Figure 6. Gate Charge Characteristics

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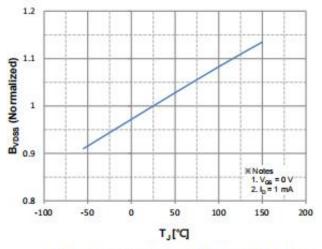


Figure 7. Breakdown Voltage Variation vs. Temperature

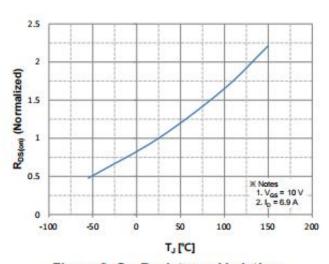


Figure 8. On-Resistance Variation vs. Temperature

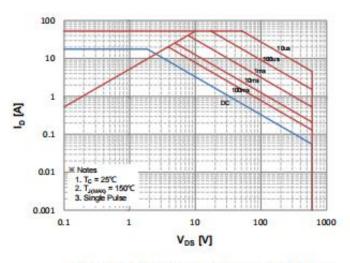


Figure 9. Maximum Safe Operating Area

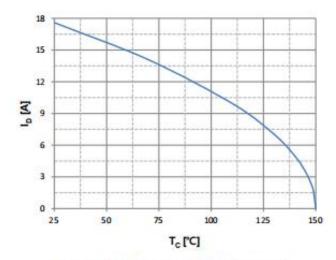


Figure 10. Maximum Drain Current vs. Case Temperature

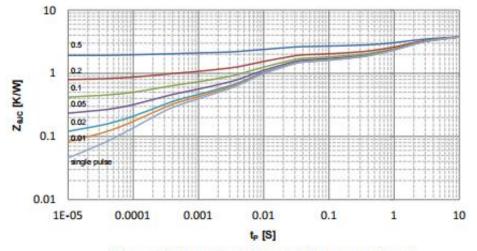


Figure 11. Transient Thermal Response Curve

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Test Circuits and Waveforms



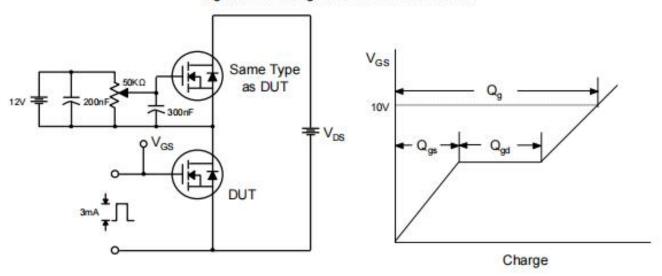


Fig 13. Resistive Switching Test Circuit & Waveforms

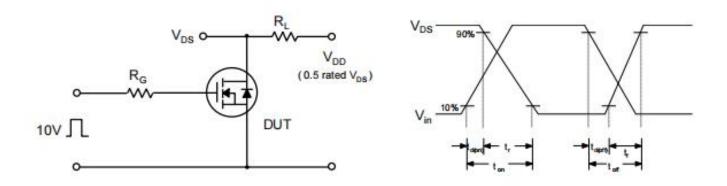
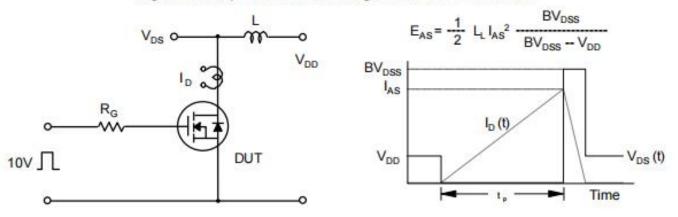


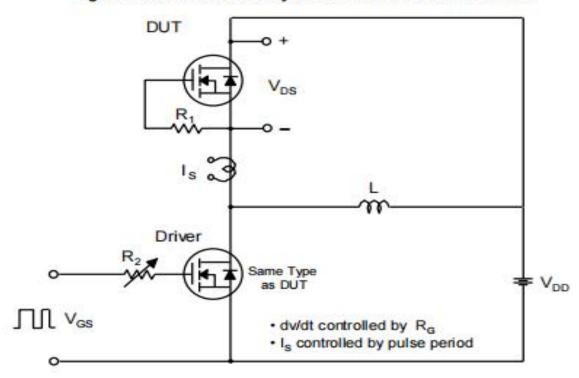
Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms

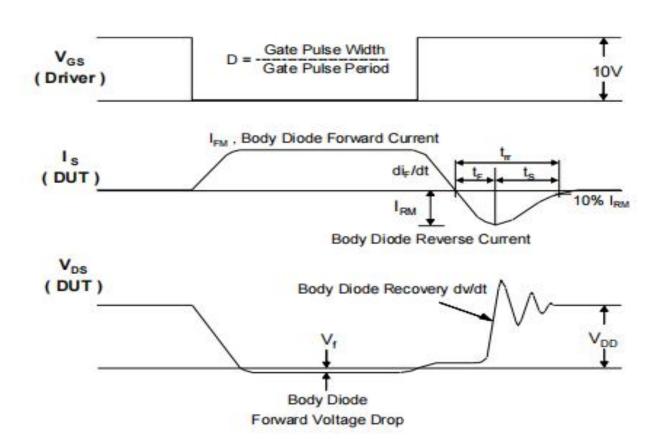




Test Circuits and Waveforms

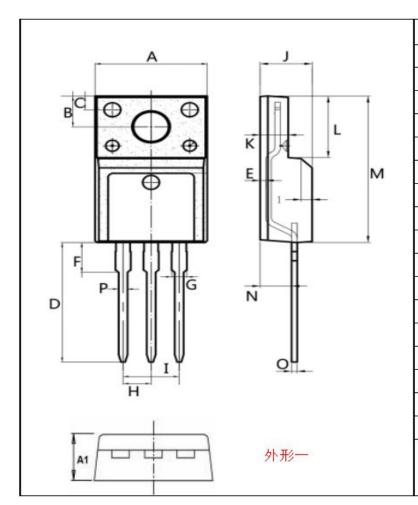
Fig 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms





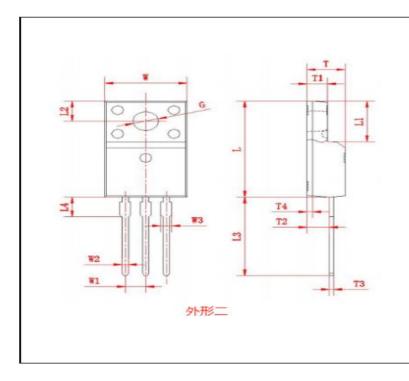


Package outline drawing(TO-220F Unit: mm)



Dim.	Min.	Max.
Α	9.95	10.36
A1	4.5	5.0
В	2.95	3.25
С	1.25	1.45
D	12.60	13.60
E	0.40	0.60
F	2.8	3.5
G	1.30	1.45
Н	(2.54	1)
1	(5.08)	
J	4.60	4.75
K	2.45	2.65
L	6.5	6.8
М	15.4	16.0
N	2.25	3.05
0	0.45	0.55
Р	0.70	0.90

All Dimensions in millimeter



Dim.	Min.	Max.		
W	9.95	10.36		
W1	(2.54)			
W2	0.70	0.90		
W3	1.25	1.47		
L	15.67	16.07		
L1	6.48	6.88		
L2	3.2	3.4		
L3	12.6	13.6		
L4	(3.23	3)		
Т	4.50	4.90		
T1	2.34	2.74		
T2	2.25	2.95		
Т3	0.45	0.60		
T4	(0.	70)		
G	3.08	3.28		



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